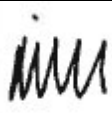




# CUS100ME

# RELIABILITY DATA

| DWG. No.   |   |   |
|--|---|---|
| APPD   | CHK   | DWG   |
|  |  |  |

**I N D E X**

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※Test results are typical data.

## 1. Calculated Values for MTBF

MODEL : CUS100ME-24

### Calculating Method

Calculated based on part count reliability projection of Telcordia (\*1).

Individual failure rates  $\lambda_G$  is given to each part and MTBF is calculated by the count of each part.

\*1: Telcordia Document “Reliability Prediction Procedure for Electronic Equipment”  
(Document number SR-332 Issue3 ,Method I, Quality level II)

Formula:

$$MTBF = \frac{1}{\lambda_{equip}} \times 10^6 = \frac{1}{\sum_{i=1}^n n_i (\lambda_G \pi_Q)_i} \times 10^6 (hours)$$

$\lambda_{equip}$  = Total Equipment Failure Rate (Failure /10<sup>6</sup> Hours )

$\lambda_G$  = Generic failure rate for the i<sup>th</sup> generic part (Failure / 10<sup>6</sup> Hours)

$n_i$  = Quantity of i<sup>th</sup> part

$n$  = Number of different generic part categories

$\pi_Q$  = Generic quality factor for the ith generic part ( $\pi_{Q=1}$ )

### MTBF Values

Environmental factor: G<sub>B</sub> (Ground, Benign)

| Line Input | Output Volts | Load  | T <sub>amb</sub> | MTBF (hrs) |
|------------|--------------|-------|------------------|------------|
| 230V       | 24V          | 4.16A | 20C              | 19,181,479 |
| 230V       | 24V          | 4.16A | 30°C             | 10,719,765 |
| 230V       | 24V          | 4.16A | 40°C             | 5,734,828  |
| 230V       | 24V          | 4.16A | 50°C             | 3,003,623  |

2. Components Derating List

MODEL: CUS100ME-24


| Location No.                         | Vin = 100VAC  | Load = 100%               | Ta = 50°C  |
|--------------------------------------|---|---------------------------|------------|
| XD8<br>FURS360B<br>Fagor             | Tjmax=175°C<br>Pd=0.5W<br>Tj = Tc + ((θ j-c) × Pd) =121°C<br>D.F.=69.1%   | θ j-c=20°C/W<br>ΔTc=10°C  | Tc=111°C   |
| XD10<br>S5MB<br>Taiwan Semiconductor | Tjmax=150°C<br>Pd=0.5W<br>Tj = Tc + ((θ j-c) × Pd) =129.9°C<br>D.F.=86.6% | θ j-c=13°C/W<br>ΔTc=6.5°C | Tc=123.4°C |
| XD11<br>S5MB<br>Taiwan Semiconductor | Tjmax=150°C<br>Pd=0.5W<br>Tj = Tc + ((θ j-c) × Pd) =129.9°C<br>D.F.=86.6% | θ j-c=13°C/W<br>ΔTc=6.5°C | Tc=123.4°C |
| XD12<br>S5MB<br>Taiwan Semiconductor | Tjmax=150°C<br>Pd=0.5W<br>Tj = Tc + ((θ j-c) × Pd) =129.9°C<br>D.F.=86.6% | θ j-c=13°C/W<br>ΔTc=6.5°C | Tc=123.4°C |
| XD13<br>S5MB<br>Taiwan Semiconductor | Tjmax=150°C<br>Pd=0.5W<br>Tj = Tc + ((θ j-c) × Pd) =129.9°C<br>D.F.=86.6% | θ j-c=13°C/W<br>ΔTc=6.5°C | Tc=123.4°C |
| XQ1<br>IPD60R400CEAUMA1<br>Infineon  | Tjmax=150°C<br>Pd=0.36W<br>Tj = Tc + ((θ j-c) × Pd) =125°C<br>D.F.=83.4%  | θ j-c=4°C/W<br>ΔTc=1.4°C  | Tc=123.6°C |
| XQ2<br>IPD60R400CEAUMA1<br>Infineon  | Tjmax=150°C<br>Pd=0.36W<br>Tj = Tc + ((θ j-c) × Pd) =125°C<br>D.F.=83.4%  | θ j-c=4°C/W<br>ΔTc=1.4°C  | Tc=123.6°C |
| XQ3<br>IPD60R400CEAUMA1<br>Infineon  | Tjmax=150°C<br>Pd=1W<br>Tj = Tc + ((θ j-c) × Pd) =130°C<br>D.F.=86.7%     | θ j-c=4°C/W<br>ΔTc=4°C    | Tc=126°C   |
| XQ4<br>IPD60R400CEAUMA1<br>Infineon  | Tjmax=150°C<br>Pd=1W<br>Tj = Tc + ((θ j-c) × Pd) =130°C<br>D.F.=86.7%     | θ j-c=4°C/W<br>ΔTc=4°C    | Tc=126°C   |
| XQ5<br>2SK3018T106<br>ROHM           | Tjmax=150°C<br>Pd=0W<br>Tj = Tc + ((θ j-c) × Pd) =100°C<br>D.F.=66.7%     | θ j-c=625°C/W<br>ΔTc=0°C  | Tc=100°C   |

| <b>Location No.</b>                   | <b>Vin = 100VAC</b>  | <b>Load = 100%</b>         | <b>Ta = 50°C</b> |
|---------------------------------------|--|----------------------------|------------------|
| XQ105<br>BSC039N06NSATMA1<br>Infineon | Tjmax=150°C<br>Pd=0.44W<br>Tj = Tc + ((θ j-c) × Pd) =135.8°C<br>D.F.=90.5% | θ j-c=20°C/W<br>ΔTc=8.8°C  | Tc=127°C         |
| XQ106<br>BSC039N06NSATMA1<br>Infineon | Tjmax=150°C<br>Pd=0.39W<br>Tj = Tc + ((θ j-c) × Pd) =134.7°C<br>D.F.=89.8% | θ j-c=20°C/W<br>ΔTc=7.7°C  | Tc=127°C         |
| XU1<br>TEA1716T<br>NXP                | Tjmax=150°C<br>Pd=0W<br>Tj = Tc + ((θ j-c) × Pd) =99.9°C<br>D.F.=66.6%     | θ j-c=90°C/W<br>ΔTc=0°C    | Tc=99.9°C        |
| XU100<br>TEA1995T                     | Tjmax=150°C<br>Pd=0W<br>Tj = Tc + ((θ j-c) × Pd) =100.5°C<br>D.F.=67%      | θ j-c=140°C/W<br>ΔTc=0°C   | Tc=100.5°C       |
| XD100<br>NCP431B<br>On-Semi           | Tjmax=150°C<br>Pd=0.1W<br>Tj = Tc + ((θ j-c) × Pd) =91.4°C<br>D.F.=60.9%   | θ j-c=80°C/W<br>ΔTc=10.6°C | Tc=80.8°C        |
| XD102<br>NCP431B<br>On-Semi           | Tjmax=150°C<br>Pd=0.02W<br>Tj = Tc + ((θ j-c) × Pd) =95.5°C<br>D.F.=63.7%  | θ j-c=80°C/W<br>ΔTc=1.4°C  | Tc=94.1°C        |

### 3. Main components temperature rise $\Delta T$ list

MODEL: CUS100ME-12

Measuring conditions

|  |  |
|--|--|
| <p>Mounting Method</p> <p>Standard Mounting (A) Open Frame</p> |  |
| Input Voltage (VAC)  | 90   |
| Output Voltage (VDC)   | 12   |
| Output Current (A)   | 8.313  |

Measuring Results

| Output Derating |                       | $\Delta T$ Temperature Rise ( $^{\circ}\text{C}$ ) |  |
|-----------------|-----------------------|--|--|
|                 |                       | $I_o = 100\%$<br>$T_a = 50^{\circ}\text{C}$        | $I_o = 60\%$<br>$T_a = 70^{\circ}\text{C}$ |
| Location No.    | Parts Name            | Mounting(A)  | Mounting (A)                               |
| XD13            | Bridge Diode          | 60.7   | 35.7                                       |
| XQ3             | Boost FET             | 58.3   | 34.3                                       |
| XD8             | Boost Diode           | 61.6   | 38.3                                       |
| XQ2             | Primary FET           | 59.6   | 37.8                                       |
| XQ106           | Secondary FET         | 51.0   | 32.9                                       |
| XU101           | Optocoupler           | 43.0   | 28.1                                       |
| XU102           | Optocoupler           | 39.1   | 26.7                                       |
| L1              | Common Mode Choke     | 47.0   | 26.0                                       |
| L2              | Boost Choke           | 51.6   | 31.3                                       |
| TX100           | Transformer Primary   | 55.6   | 37.6                                       |
| TX100           | Transformer Secondary | 54.3   | 36.2                                       |
| C1              | Resonant Cap          | 44.0   | 28.4                                       |
| C2              | Auxilliary Cap        | 34.7   | 23.9                                       |
| C3              | X Cap                 | 25.7   | 14.8                                       |
| C6              | Boost Cap             | 41.9   | 26.0                                       |
| C7              | X Cap                 | 34.4   | 21.5                                       |
| C102            | Output Cap            | 37.3   | 23.8                                       |
| F1              | Fuse                  | 37.4   | 19.8                                       |
| XR112           | Sense Resistor        | 65.4   | 49.6                                       |
| XD13            | Bridge Diode          | 60.7   | 35.7                                       |



## 5. Vibration Test

**MODEL: CUS100ME**

### (1) Vibration Test Class

Frequency Variable Endurance Test

### (2) Equipment Used

Controller: LDS Dactron Comet  
Vibrator: V830-335 T M8 R-CE  
Accelerometer: DeltaTron 4533-B

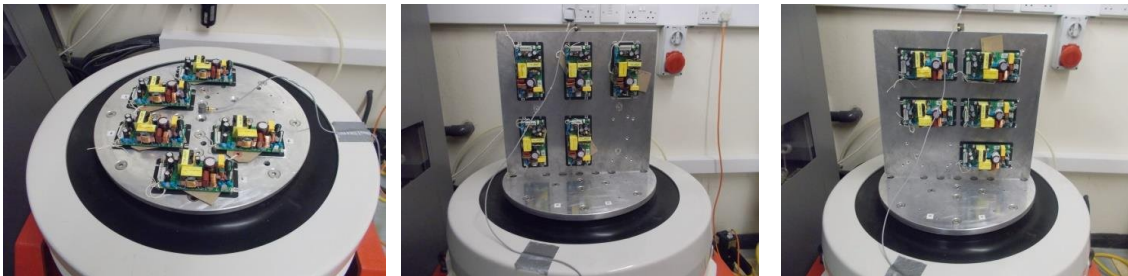
### (3) The Number of D.U.T. (Device Under Test)

5 Units

### (4) Test Conditions

|                  |                   |               |                  |
|------------------|-------------------|---------------|------------------|
| Sweep Frequency: | 10 - 500Hz        | Direction:    | X, Y, Z          |
| Sweep Time:      | 1 minute          | Test Time:    | 1 hour each axis |
| Acceleration:    | 2.2G              | Non-operation |                  |
| Mounting:        | Standard Mounting |               |                  |

### (5) Test Method



Fix the PSUT on the mounting rail with stopper on each corner.  
Standard mounting position as per picture above.

### (6) Acceptable Conditions

1. Not to be broken.
2. No abnormal output after test.

### (7) Test Results

Visually OK and functions after test.



**6. Thermal shock test**

**MODEL : CUS100ME-24**

**(1) Equipment used**

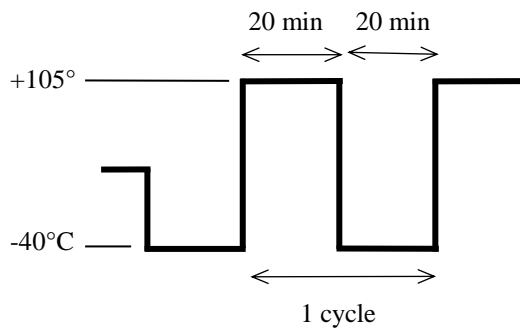
Thermal shock chamber Thermotron

**(2) The number of PSUT. (Power Supply Under Test)**

1 unit

**(3) Test Conditions**

|                      |                 |
|----------------------|-----------------|
| Ambient Temperature: | -40°C ↔ 105°C   |
| Test Time:           | 20 min ~ 20 min |
| Test Cycle:          | 523 cycles      |
| Not Operating        |                 |



**(4) Test Method**

Before the test, check if there is no abnormal output and put the PSUT in the testing chamber. Then test it in above cycles. After the test is completed, leave it for 1 hour at the room temperature and check to make sure that there is no abnormal output.

**(5) Test Results**

Visually and electrically OK.